Searcn Notes					

Application/Control	No. Applicant(s)/Par Reexamination	Applicant(s)/Patent under Reexamination	
10/721,048	KLEIN ET AL.		
Examiner	Art Unit		
Jung Kim	2132		

SEARCHED				
Class	Subclass	Date	Examiner	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH (INCLUDING SEAR		)
	DATE	EXMR
updated east search	10/27/2007	JK
726/4,14 and 370/400-406	10/27/2007	JK
see enclosed search history		